

EN 300 330-1/ EN 300 330-2 RADIO TEST REPORT

On Behalf of

Shanghai Anviz Technology Co.Ltd Fingerprint & RFID Time Attendance Model No.: A300

Prepared for : Shanghai Anviz Technology Co.Ltd

Address : 2th Floor, 4289 Jindu Road, Shanghai China

Prepared By :	Shenzhen Alpha Prod	luct Testing Co., Ltd.	

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DECLARATION

Applicant	:	Shanghai Anviz Technology Co.Ltd
Manufacturer	:	Shanghai Anviz Technology Co.Ltd
Product	:	Fingerprint & RFID Time Attendance
(A)Model No.	:	A300

(B)Trade Name :



(C)Power supply : DC 5V from USB port

Measurement Procedure Used:

ETSI EN 300 330-1 V1.7.1: Electromagnetic compatibilityand Radio spectrum Matters (ERM);Short Range Devices (SRD);Radio equipment in the frequency range9 kHz to 25 MHz and inductive loop systems in the frequency range 9 kHz to 30 MHz;Part 1: Technical characteristics and test methods

ETSI EN 300 330-2 V 1.5.1: Electromagnetic compatibility and Radio spectrum Matters (ERM); Short Range Devices (SRD); Radio equipment in the frequency range 9 kHz to 25 MHz and inductive loop systems in the frequency range 9 kHz to 30 MHz; Part 2: Harmonized EN covering the essential requirements of article 3.2 of the R&TTE Directive

The device described above is tested by Shenzhen Alpha Product Testing Co., Ltd. The measurement results are contained in this test report and Shenzhen Alpha Product Testing Co., Ltd. is assumed full of responsibility for the accuracy and completeness of these measurements. Also, this report shows that the EUT (Equipment Under Test) is technically compliant with the EN 300 330-1 and EN 300 330-2 requirements.

This report applies to above tested sample only and shall not be reproduced in part without written approval of Shenzhen Alpha Product Testing Co., Ltd.

Tested by (name + signature).....:

Peter Kang Test Engineer

Simple Guan Project Manager



Date of issue.....

Approved by (name + signature).....:

July 25, 2016

1. General Information

1.1. Description of Device (EUT)

EUT Name	:	Fingerprint & RFID Time Attendance
Model No.	:	A300
DIFF	:	N/A
Trademark	:	Λννίζ
Power supply	:	DC 5V from USB port
Radio Technology	:	13.56MHz SRD
Operation frequency	:	13.56MHz
Antenna Type	:	Integrated Antenna, Maximum Gain is 38dBi.
Software version		N/A
Hardware version		N/A
Intend use environment	:	Residential, commercial and light industrial environment
Applicant	:	Shanghai Anviz Technology Co.Ltd
Address	:	2th Floor,4289Jindu Road,Shanghai China
Manufacturer		Shanghai Anviz Technology Co.Ltd
Address		2th Floor,4289Jindu Road,Shanghai China

1.2. Accessories of device (EUT)

Accessories1	:	N/A
Model		N/A
Input		N/A
Output		N/A
Accessories2	:	N/A
Model		N/A

1.3. Test Lab information

Shenzhen Alpha Product Testing Co., Ltd. Building B, East Area of Nanchang Second, Industrial Zone, Gushu 2nd Road, Bao'an, Shenzhen, China

March 25, 2015 File on Federal Communication Commission Registration Number: 203110

July 18, 2014 Certificated by IC Registration Number: 12135A

2. Summary of test

2.1. Test Standard description:

ETSI EN 300 330-1 V1.7.1: Electromagnetic compatibility and Radio spectrum Matters (ERM);Short Range Devices (SRD);Radio equipment in the frequency range9 kHz to 25 MHz and inductive loop systems in the frequency range 9 kHz to 30 MHz;Part 1: Technical characteristics and test methods

ETSI EN 300 330-2 V 1.5.1: Electromagnetic compatibility and Radio spectrum Matters (ERM); Short Range Devices (SRD); Radio equipment in the frequency range 9 kHz to 25 MHz and inductive loop systems in the frequency range 9 kHz to 30 MHz; Part 2: Harmonized EN covering the essential requirements of article 3.2 of the R&TTE Directive

CLAUSE (ETSI EN300 330)	TEST PARAMETER	RESULTS
	Transmitter Parameters	
7.2	Transmitter Carrier Output Levels	PASS
7.3	Permitted Frequency Range Of The Modulation Bandwidth	PASS
7.4	Transmitter Spurious Radiated Emission	PASS
7.5	Duty Cycle	
	Receiver Parameters	
8.3	Receiver spurious emissions	N/A

2.2. Summary of test result

2.3. Block Diagram

1. For radiated test



2.4. Test mode

Tested mode, channel, and data rate information					
Modedata rate (Mpbs)ChannelFrequency					
			(MHz)		
SRD	N/A	1	13.56		

2.5. Test Conditions

	Normal Conditions	Extreme Conditions
Temperature range	15-35℃	-10° C and 55 $^{\circ}$ C
Humidity range	40-75%	40-75%
Pressure range	86-106kPa	86-106kPa
Power supply	DC 5V from USB port	207V and 253V (declared by the
		manufacturer.)

2.6. Receiver Class

Receiver Class: (Subclause 4.1.1)

Class 1 (Safety critical SRD communication media; i.e. for devices serving systems where failure may result in a physical risk to a person)

Class 2 (Function critical SRD communication media; i.e. when a failure to operate correctly causes loss of function but does not constitute a safety hazard)

Class 3 (Non-critical SRD communication media whose failure to operate correctly causes loss of function which can be overcome by parallel means)

•		,
Item	MU	Remark
Uncertainty for Power point Conducted Emissions Test	2.42dB	
Uncertainty for Radiation Emission test in 3m chamber	3.54dB	Polarize: V
(30MHz to 1GHz)	4.1dB	Polarize: H
Uncertainty for Radiation Emission test in 3m chamber	2.08dB	Polarize: H
(1GHz to 25GHz)	2.56dB	Polarize: V
Uncertainty for radio frequency	1×10-9	
Uncertainty for conducted RF Power	0.65dB	
Uncertainty for temperature	0.2°C	
Uncertainty for humidity	1%	
Uncertainty for DC and low frequency voltages	0.06%	

2.7. Measurement Uncertainty (95% confidence levels, k=2)

2.8. Test Equipment

Equipment	Manufacture	Model No.	Serial No.	Last cal. Due to	Cal Interval
3m Semi-Anechoic	CHENYU	N/A	N/A	2018.01.18	2Year
Spectrum analyzer	Agilent	E4407B	MY46185649	2017.01.16	1Year
Receiver	R&S	ESPI	101873	2017.01.16	1Year
Receiver	R&S	ESCI	101165	2017.01.16	1Year
Bilog Antenna	SCHWARZBECK	VULB 9168	VULB9168-438	2018.01.18	2Year
Horn Antenna	SCHWARZBECK	BBHA 9120 D	BBHA 9120 D(1201)	2017.01.20	2Year
Cable	Resenberger	N/A	No.1	2017.01.16	1Year
Cable	SCHWARZBECK	N/A	No.2	2017.01.16	1Year
Cable	SCHWARZBECK	N/A	No.3	2017.01.16	1Year
Pre-amplifier	HP	HP8347A	2834A00455	2017.01.18	1Year
Pre-amplifier	Agilent	8449B	3008A02664	2017.01.18	1Year
vector Signal Generator	Agilent	N5182A	MY49060042	2016.11.16	1 Year
vector Signal	Agilent	E4438C	US44271917	2016.11.16	1 Year

Generator					
X-series USB					
Peak and Average	Agilent	U2021XA	MY54080020	2016.11.16	1 Year
Power Sensor					
X-series USB					
Peak and Average	Agilent	U2021XA	MY54110001	2016.11.16	1 Year
Power Sensor					
Signal Analyzer	Agilent	N9020A	MY48030494	2016.11.16	1 Year

3. Transmitter Carrier Output Levels

3.1. Limit(ETSI EN 300 330-1V1.7.1)

The maximum H-field strengths under normal and extreme conditions for certain frequency bands are given in table:

	Frequency range (MHz)	H-field strength limit (Hf) dBµA/m at 10 m
	0,009 ≤1 < 0,315	30
	0,009 ≤ 1 < 0,03	72 or according to note 1
	0,03 ≤ f < 0,05975	72 at 0,03 MHz descending 3 dB/oct
	0,06025 ≤ f < 0,07	or according to note 1
	0,119 ≤ f < 0,135	
	0,05975 ≤1 < 0,06025	1000
	0,07 ≤ f < 0,119	42
	0,135 ≤ f < 0,140	
	0,140 ≤ f < 0,1485	37,7
	0,1485 ≤ f < 30	-5 (see note 4)
	0,315 ≤ f < 0,600	-5
	3,155≤1<3,400	13,5
	7,400 ≤ 1 < 8,800	9
	10.2 ≤ f < 11.00	9
	6,765≤1≤6,795	
	13,553 ≤ f ≤ 13,567	42 (see note 3)
	26,957 ≤ f ≤ 27,283	State State State State
	13,553 ≤ f ≤ 13,567	60 (see notes 2 and 3)
	 apply to limits above 42 dBµA/m: for loop coll antennas with an a for loop coll antennas with an a with a correction factor. The lim 	kHz and 119 to 135 kHz, the following additional restrictions area $\ge 0,16 \text{ m}^2$ table 4 applies directly; area between 0,05 m ² and 0,16 m ² table 4 applies nit is: table value + 10 × log (area/0,16 m ²); area < 0,05 m ² the limit is 10 dB below table 4. nly.
NOTE 3:	Spectrum mask limit, see annex G).
NOTE 4:	For further information see annex	H.

3.2. Test Procedure

EUT was placed on a 0.8 m outdoor wooden table. The search antenna is placed at 3m distances from the EUT and search antenna height is from 1-4m. With the transmitter operating at continuously mode, the turntable was slowly rotated to locate the direction of maximum emission. Once maximum direction is determined, the search antenna was raised and lowered in both vertical and horizontal polarizations.

The EUT was removed from the turntable and replaced with a linearly polarized antenna connected to a calibrated RF signal generator. The RF generator was set to a measured emission frequency and the search antenna was raised and lowered to produced a maximum received reading. The generator output was increased to match the radiated emission reading measured previously, and the result expressed in dB E.I.R.P. or ERP.

3.3. Test Result

EUT: Fingerprint & RFID Time Attendance M/N:A300				
Test date: 2016-	07-24	Test site: RF s	Test site: RF site Tested by: Simple	
Test Conditions			CH:13.56MHz (dBuA/m)	
Temp	Volt	Value(3m)	Value(10m)	
25℃	230	-7.41	-29.41	
-10°C	207	-7.39	-29.39	
-10°C	253	-7.28	-29.28	42
50℃	207	-7.31	-29.31	
50° ℃	253	-7.40	-29.40	
Conclusion: PASS				
Note1: The measurement distance is 3m.				
Note2: According to F.2 of EN 300 330-1, the correction factor between 10m and 3m a				veen 10m and 3m at

13.56MHz should be 22dB.

4. Permitted Frequency Range of the Modulation Bandwidth

4.1. Limit(ETSI EN 300 330-1V1.7.1)

The permitted rang of the modulation bandwidth shall be within 13.553-13.567MHz.

4.2. Test Procedure

- 1). The EUT was placed on a turn table which is 0.8m above ground plane.
- 2). The EUT was modulated by normal signal,
- Set SPA Center Frequency = fundamental frequency, RBW=VBW= 100 Hz, Span =500 Hz.
- 4), Both normal test condition and extreme test condition applied

4.3. Test Result

EUT: Fingerprint & RFID Time Attendance M/N:A300					
Test date: 2016-07-24		Test site: RF s	Test site: RF site Tested by		
Test Conditions		CH:13.56MHz (MHz)		Limit	
Temp	Volt	FL	FH	(MHz)	
25℃	230	13.561	13.565		
-10°C	207	13.561	13.565	FL>13.553 FH<13.567	
-10°C	253	13.561	13.565		
50° ℃	207	13.561	13.565	FH<13.307	
50° ℃	253	13.561	13.565		
Conclusion: PA	SS				

5. Transmitter Spurious Radiated Emission

5.1. Limit(ETSI EN 300 330-1V1.7.1)

The radiated field strength of the spurious domain emissions below 30 MHz shall not exceed the generated H-field $dB\mu A/m$ at 10 m given in table:

State	Frequency 9 kHz ≤ f < 10 MHz	Frequency 10 MHz ≤ f < 30 MHz
Operating	27 dBµA/m at 9 kHz descending 3 dB/oct	-3,5 dBµA/m
Standby	5,5 dBµA/m at 9 kHz descending 3 dB/oct	-22 dBµA/m

The power of any radiated emission shall not exceed the values given in table :

State	47 MHz to 74 MHz 87,5 MHz to 118 MHz 174 MHz to 230 MHz 470 MHz to 862 MHz	Other frequencies between 30 MHz to 1 000 MHz
Operating	4 nW	250 nW
Standby	2 nW	2 nW

5.2. Test Procedure

- 1, The EUT was placed on a 1.5m high table in the chamber and turned on in continuously TX mode.
- 2, All the spurious emissions at 3m distance was measured and recorded with receive antenna in both vertical and horizontal by rotating the turntable and by lowering the receive antenna, and the spectrum analyser was set as below

RBW:100KHz

VBW:30KHz

Detector mode: PK mode

Sweep time: Auto

For measuring emissions that exceed the level of 6dB below the applicable limit, the resolution bandwidth shall be switched to 30KHz and the span shall be adjusted accordingly. If the level does not change by more than 2dB, it is a narrowband emissions, if the level changes by more than 2dB, the emission is a wideband emission.

- 3, The EUT was then removed and replaced with a substitution antenna in the same position and the substitution antenna must have the same polarization with the receive antenna.
- 4, A signal which have the same frequency obtained in step 2 was fed to the substitution antenna ,the receive antenna was raised and lowered to obtain a maximum reading at the test receiver, the level of the signal generator was adjusted until the measured field strength level in step 2 was obtained, recorded the level of the signal generator.
- 5, Repeated step 4 with both antenna polarizations
- 6, The spurious emissions is equal to the power supplied by the signal generator and corrections due to the gain of the substitution antenna and the cable loss between the signal generator and the substitution antenna.

5.3. Test Result

est Date: 2016	-07-24	Test site: RF	Site	Tested b	Tested by: simple		
mbient Tempe	rature: 23°C	Relative Hur	Relative Humidity: 60%				
		Test resul	t 9KHz-30MHz				
		Test Mod	le: 13.56MHz				
Frequency (MHz)	Antenna polarization	Result (dBm)	Limit (dBm)	Margin (dB)	Conclusion		
	H		27 dBuA/m at				
	Н		9KHz descending 3dB/oct				
	Н		(9KHz – 10MHz)				
	Н		-3.5 dBuA/m				
	Н		(10MHz –				
	Н		30MHz)				
	V		27 dBuA/m at				
	V		9KHz descending 3dB/oct				
	V		(9KHz – 10MHz)				
	V		-3.5 dBuA/m				
	V		(10MHz –				
	v		30MHz)				

too small to be measured.

EUT: Fingerprin	nt & RFID Time	Attendance M/	N: A300				
Test Date: 2016	-07-24	Test site: RF S	Site	Tested	Tested by: simple		
Ambient Tempe	erature: 23°C	Relative Humi	Relative Humidity: 60%				
		Test result	30MHz-1GHz				
		Test Mode	: 13.56MHz				
Frequency	Antenna	Result	Limit	Margin	Conclusion		
(MHz)	polarization	(dBm)	(dBm)	(dB)	Conclusion		
174.63	Н	-64.35	-54.00	-10.35	PASS		
182.39	Н	-65.24	-54.00	-11.24	PASS		
273.47	Н	-64.77	-36.00	-28.77	PASS		
436.58	Н	-62.63	-36.00	-26.63	PASS		
581.27	Н	-67.42	-54.00	-13.42	PASS		
753.34	Н	-65.26	-54.00	-11.26	PASS		
249.62	V	-63.17	-36.00	-27.17	PASS		
371.84	V	-64.83	-36.00	-28.83	PASS		
453.57	V	-63.43	-36.00	-27.43	PASS		
482.71	V	-65.28	-54.00	-11.28	PASS		
509.14	V	-65.35	-54.00	-11.35	PASS		
636.28	V	-66.26	-54.00	-12.26	PASS		

6. Duty Cycle (RFID)

6.1. Limit(ETSI EN 300 330-1V1.7.1)

In a period of 1 hour the duty cycle shall not exceed the values given in table:

Duty cycle Class	Duty cycle ratio
1	< 0,1 %
2	< 1,0 %
3	< 10 %
4	Up to 100 %

6.2. Test Procedure

- 1). The EUT was placed on a turn table which is 0.8m above ground plane.
- 2). The EUT was modulated by normal signal,
- 3). Set SPA Center Frequency = fundamental frequency, RBW=VBW= 470 Hz, Span=0 Hz, Sweep Time=80.82ms
- 4). Record the on time and off time

6.3. Test Result

The EUT is declared by manufacturer as a duty cycle ratio of up to 100%.

7. Receiver Spurious Radiated Emission

7.1. Limit(ETSI EN 300 330-1V1.7.1)

The spurious components below 30 MHz shall not exceed the generated H-field $dB\mu A/m$ values at 10 m according to table

Frequency 9 kHz ≤ f < 10 MHz	Frequency 10 MHz ≤ f < 30 MHz
5.5 dBµA/m at 9 kHz descending 3 dB/oct	-22 dBμA/m

7.2. Test Procedure

- 1, The EUT was placed on a 1.5m high table in the chamber and turned on in continuously TX mode.
- 2, All the spurious emissions at 3m distance was measured and recorded with receive antenna in both vertical and horizontal by rotating the turntable and by lowering the receive antenna, and the spectrum analyser was set as below

RBW:100KHz; VBW:30KHz; Detector mode: PK mode; Sweep time: Auto For measuring emissions that exceed the level of 6dB below the applicable limit, the resolution bandwidth shall be switched to 30KHz and the span shall be adjusted accordingly. If the level does not change by more than 2dB, it is a narrowband emissions, if the level changes by more than 2dB, the emission is a wideband emission.

- 3, The EUT was then removed and replaced with a substitution antenna in the same position and the substitution antenna must have the same polarization with the receive antenna.
- 4, A signal which have the same frequency obtained in step 2 was fed to the substitution antenna ,the receive antenna was raised and lowered to obtain a maximum reading at the test receiver, the level of the signal generator was adjusted until the measured field strength level in step 2 was obtained, recorded the level of the signal generator.
- 5, Repeated step 4 with both antenna polarizations
- 6, The spurious emissions is equal to the power supplied by the signal generator and corrections due to the gain of the substitution antenna and the cable loss between the signal generator and the substitution antenna.

7.3. Test Result

These requirements do not apply to receives used in combination with permanently co-located transmitters continuously transmitting. Co-located is defined as < 3m. in these case the receivers will be tested together with the transmitter in operating mode.

The transmitter and receiver of sample must locate with 3m. therefore, the receiver is tested with the transmitter in operation mode. The test result refers to chapter 11.

8. Photos of Setup





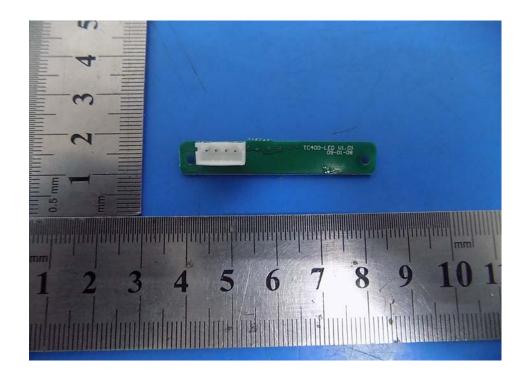
9. Photos of EUT

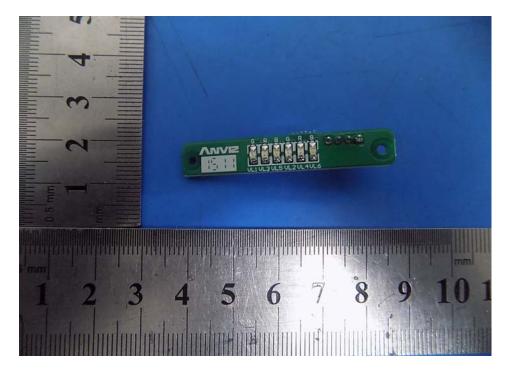


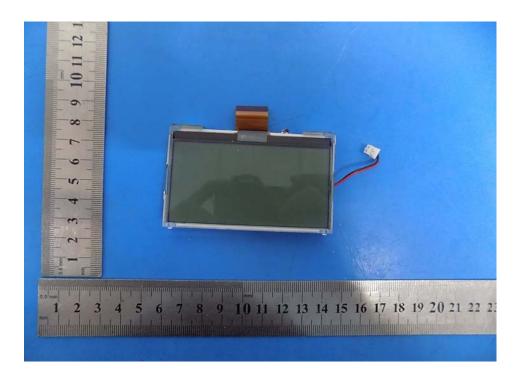


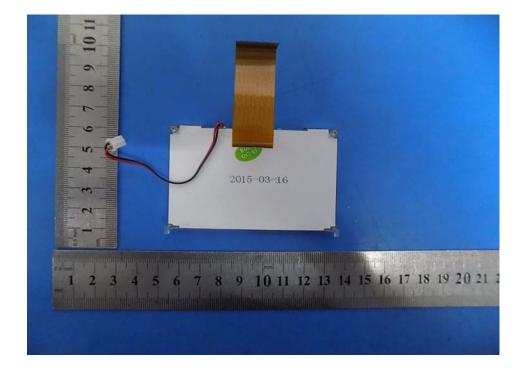


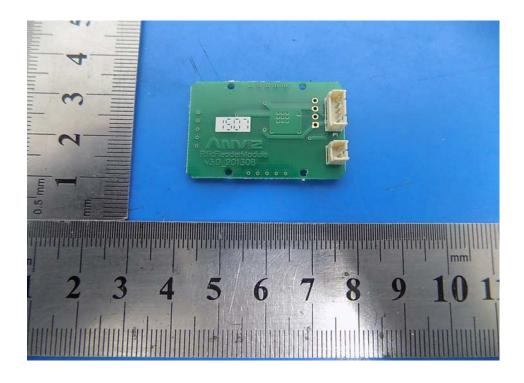


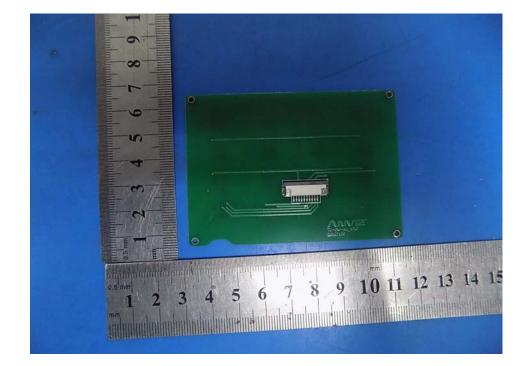


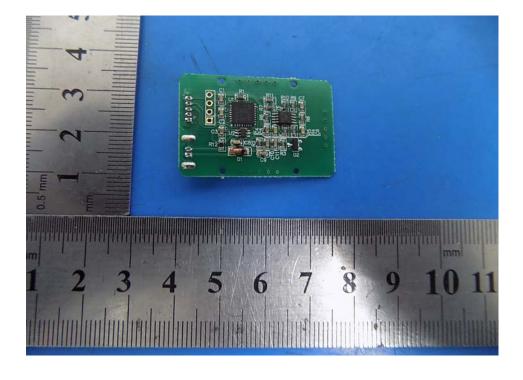


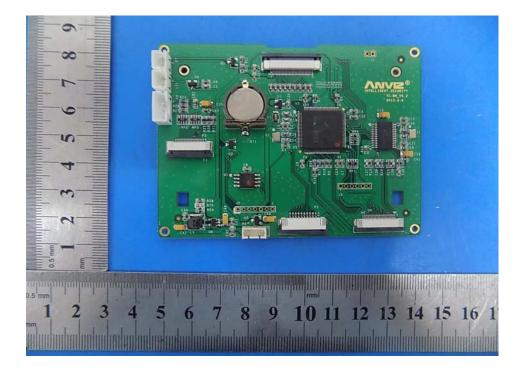


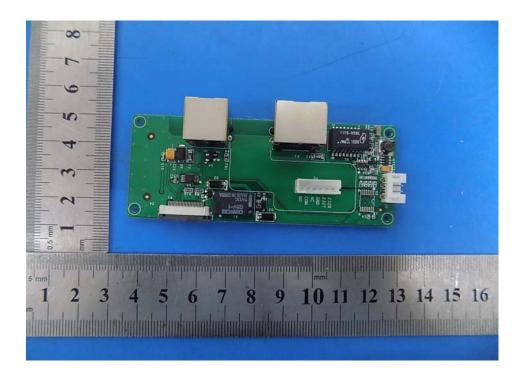


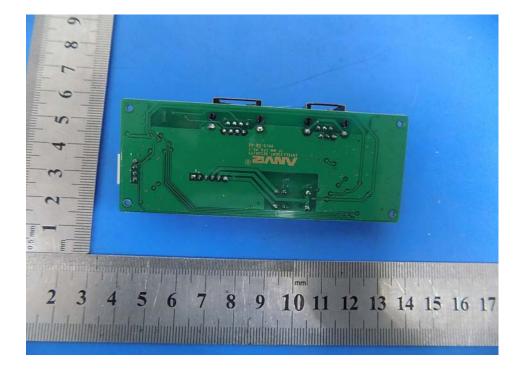


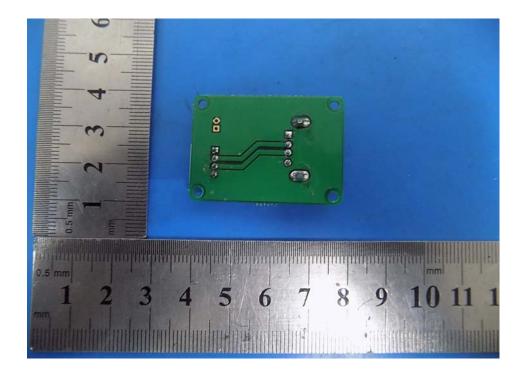


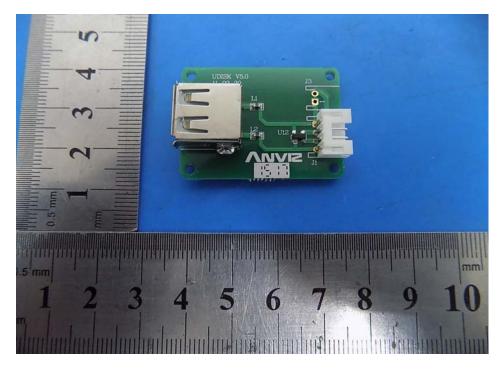


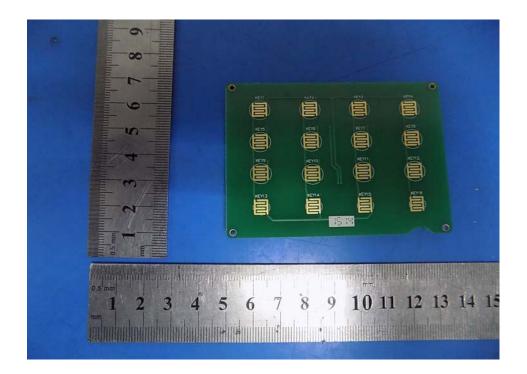


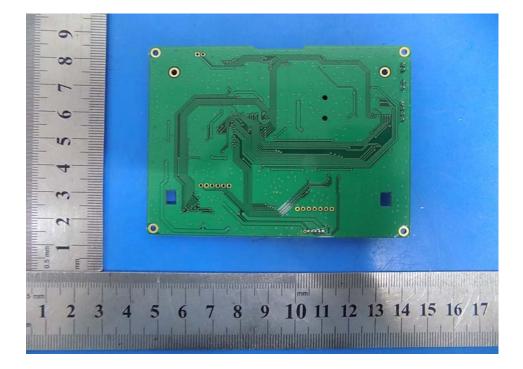


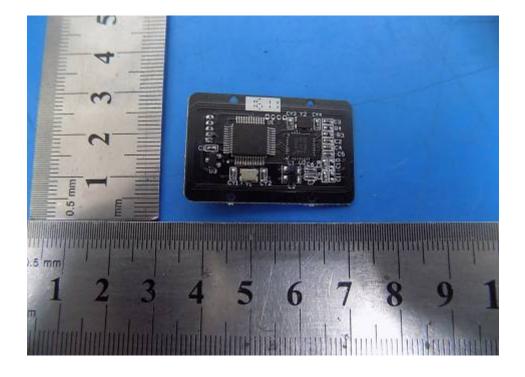














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